

Notice of References Cited	Application/Control No. 10/587,854		Applicant(s)/Patent Under Reexamination BOUIZI ET AL.	
	Examiner ELIZABETH WOOD		Art Unit 1732	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,504,074	01-2003	Verduijn et al.	585/475
*	C	US-2003/0121827	07-2003	van den Berge et al.	208/120.01
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	U	Goossens et al., "Oriented FAU Zeolite Films on Micrometer-Sized EMT crystals", Adv. Mater., 1999, 11, no.7, 561-564.
	V	Goossens et al., "Synthesis and Characterization of Epitaxial FAU-on-EMT Zeolite Overgrowth Materials", Eur. J. Inorg.Chem., 2001, 1167-1181.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.